

[APPROVAL SHEET]

(WI-FI)

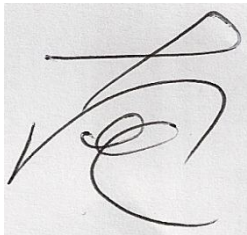
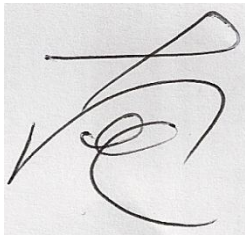
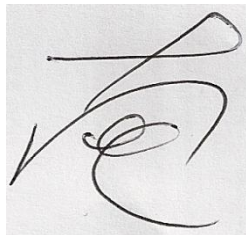


Nice Korea Components Co., Ltd

TEL : 031-470-8989

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[APPROVAL SHEET]

Product	NKCBTF-F02	
Model	SPP-R200II	
Designed by	Checked by	Approved by
		

2013. 9. 14

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– Contents –

•표지	1p
•목차	3p
1. Revision History	4p
2. Features & Applications	5p
3. Electrical Specifications	6p
4. Measurements Method & Conditions	13p
5. PCB Layout & Solder Pad size	14p
6. Antenna Dimensions	18p
7. Marking View	18p
8. Reflow Profile	19p
9. Environmental Tests	20p
10. Packaging	21p
11. Usage and Cautions	21p
12. RoHS Data	22p

1. Revision History

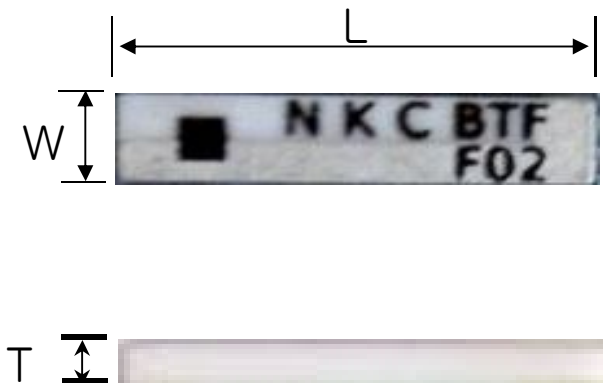
product	NKCBTF-F02	Model	SPP-R200II
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Rev. No.	Rev. Issue	Page	Designed	Date
1.0	Appro. Issue	–	KC. NAM	2013.9.14

2. Features & Applications

2.1 Features

This ceramic chip antenna is applied to 2.4 GHz ISM band applications, i.e. Bluetooth, Zigbee, Wireless LAN, etc...

형태	Bulk Ceramic	
재질	유전체	Al ₂ O ₃ (Alumina)
	전극	은(Ag)
크기 (mm)	L = 10+/- 0.1	
	W = 2+/- 0.1	
	T = 1.2+/- 0.1	
Weight	97~100 mg	

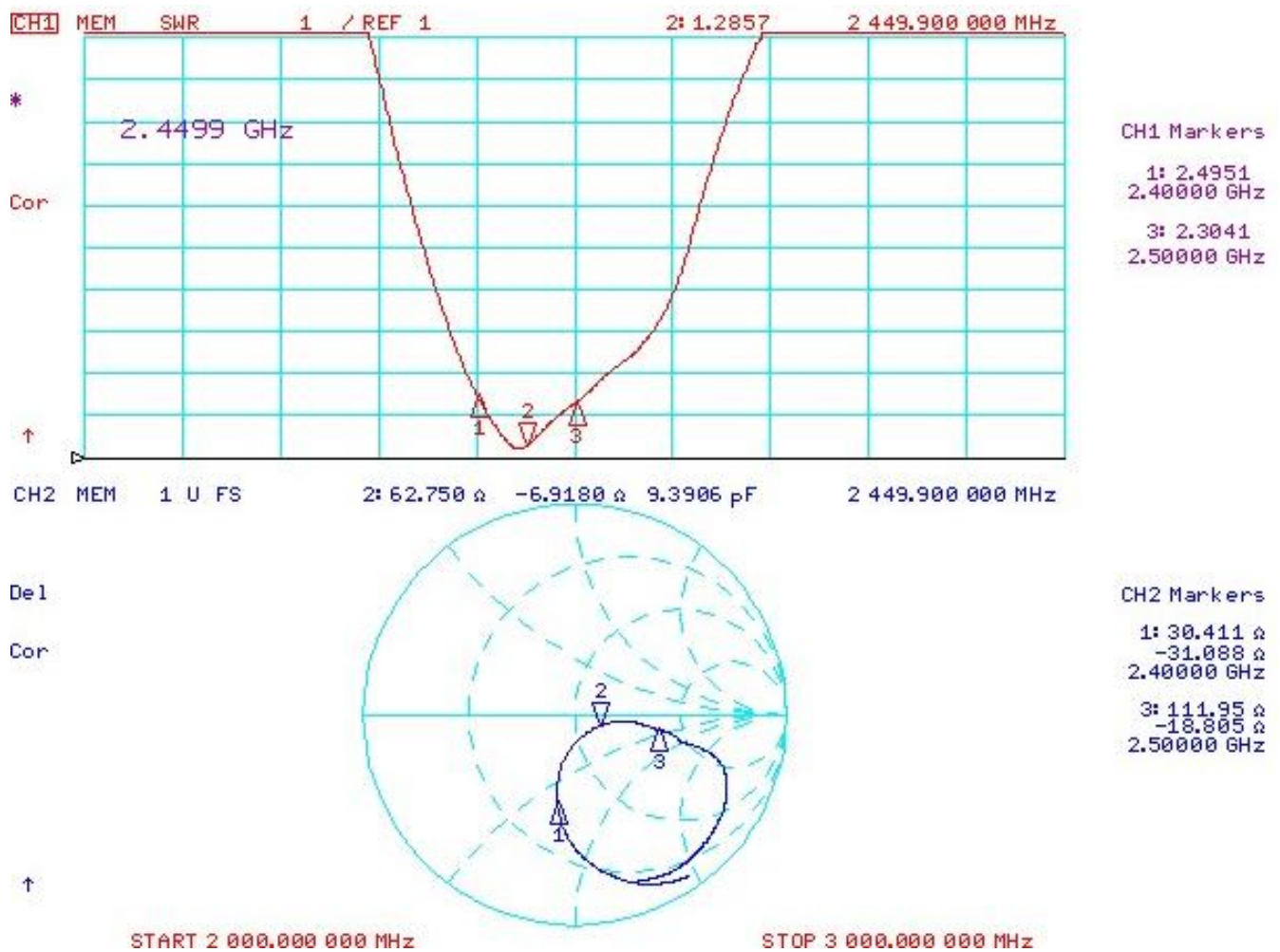
3. Electrical Specifications

3-1.

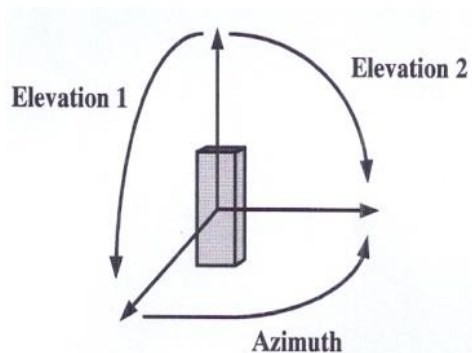
- * All item are measured in room temperature (24~26 'C).
- * All item are measured at customer set condition.

No.	Items	Typical Data
1	Frequency (MHz)	2400 ~2500
2	VSWR	3 : 1
3	Total Gain (Peak/AVG.) [dBi]	3.91 / -3.53
4	Impedance	50 ohm
5	Polarization	Linear

3-2. VSWR (S₁₁) of USER SET condition

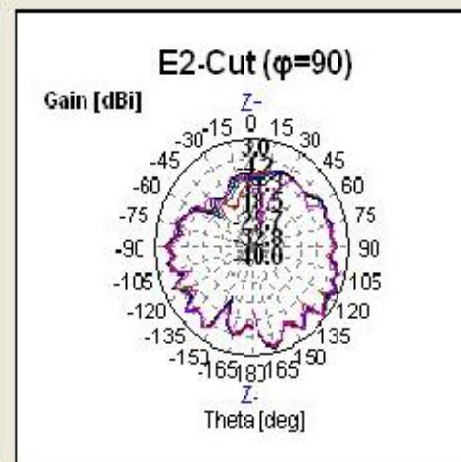
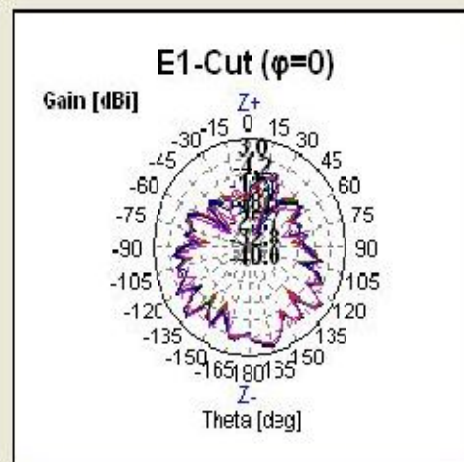
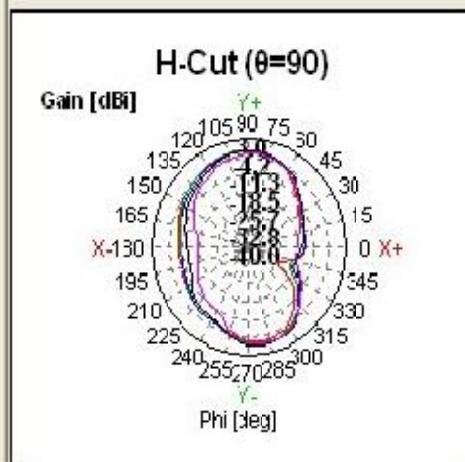


3-3. Radiation Patterns



Theta	Vertical Field of measured plane
Phi	Horizontal Field of measured plane

Gain(dBi)	Total Gain (Peak/Avg) [dBi]		3.91 / -3.53	
	Azimuth	H-pole	Peak	2.35
			Avg	-5.65
	Elevation	V-pole	Peak	0.73
			Avg	-7.67

[illegible]

Plot Data

Polarization :

Frequency :

[GHz]



Graph Option

Style

☒ Polar ☐ Rectangular

Zoom

H-Cut E1-Cut E2-Cut

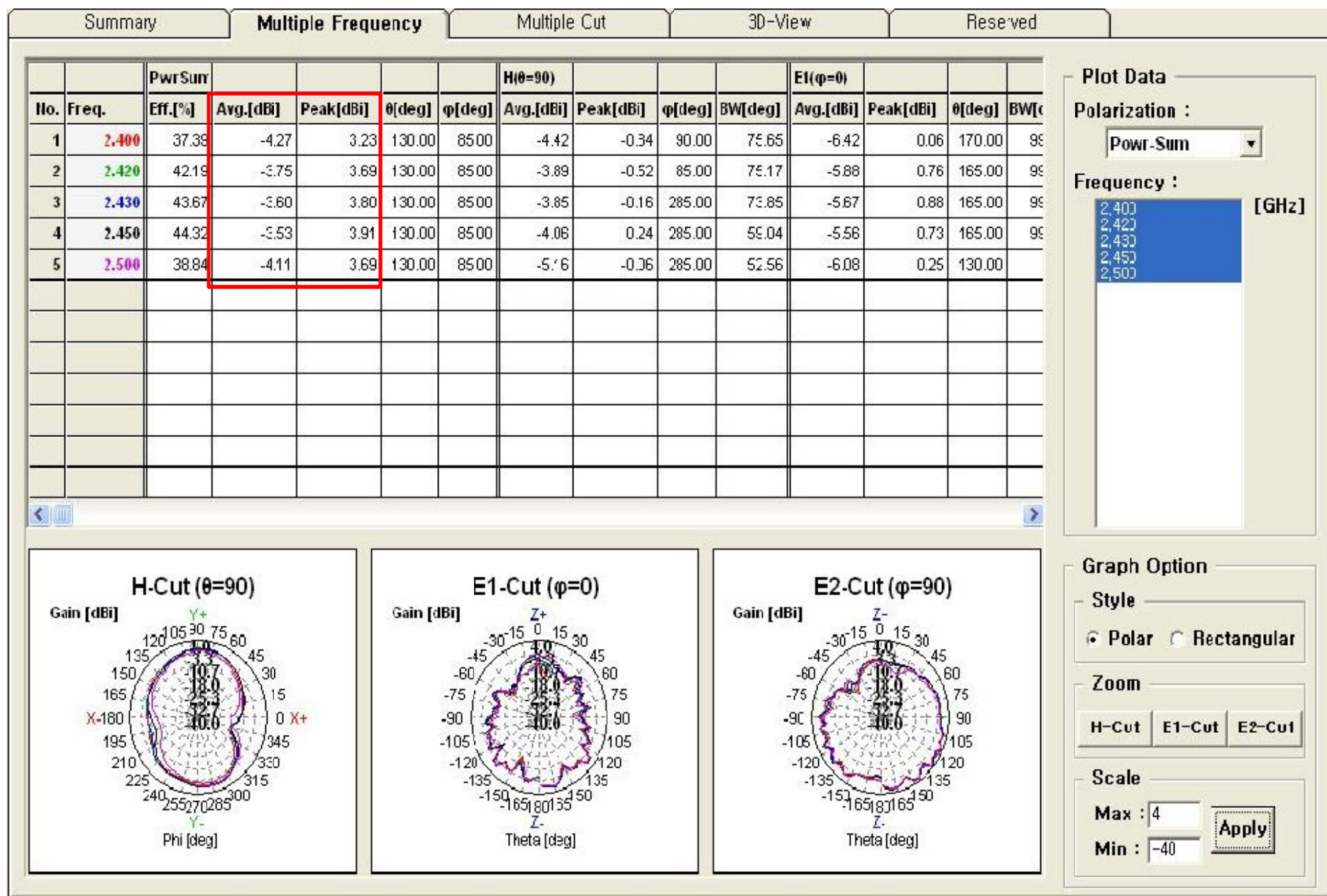
Scale

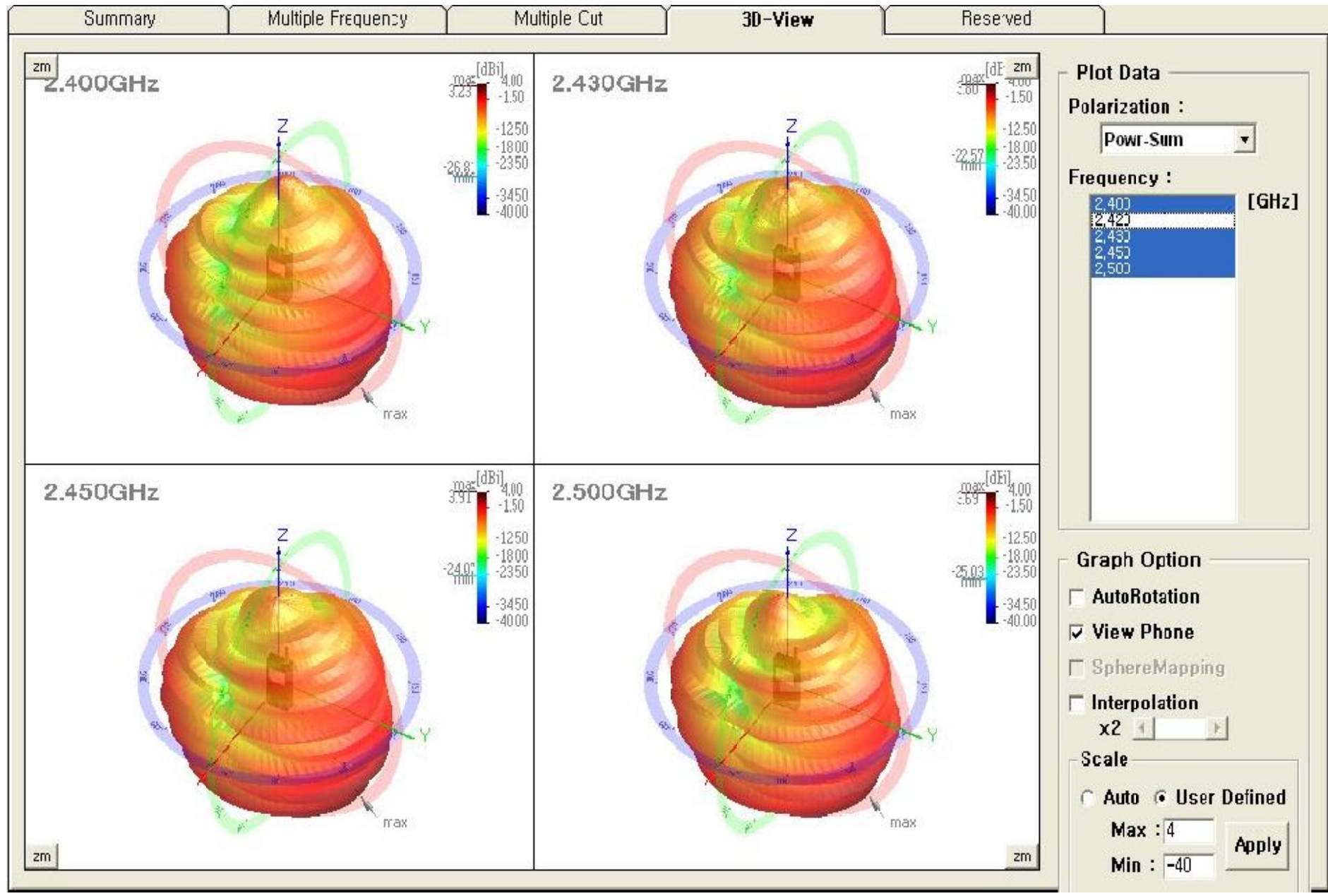
Max : 3

Min : -4

Apply

[illegible]

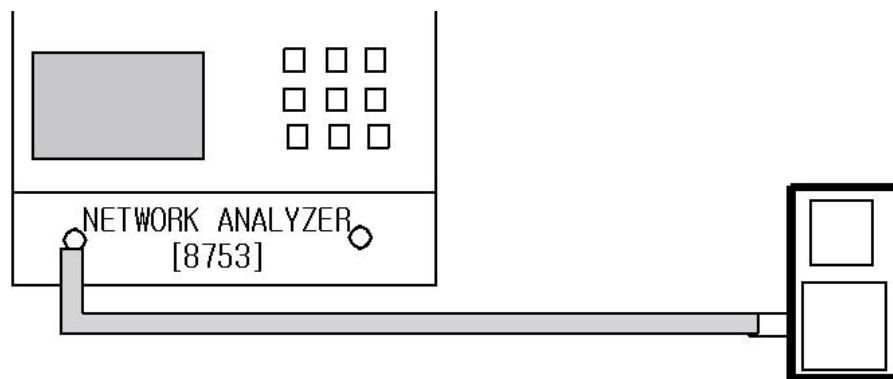




4. Measurements Method & Conditions

The measurement of antenna performance is measurement of gain, radiation pattern using ORBIT/FR apparatus in Anechoic chamber and measurement of VSWR using Network analyzer.

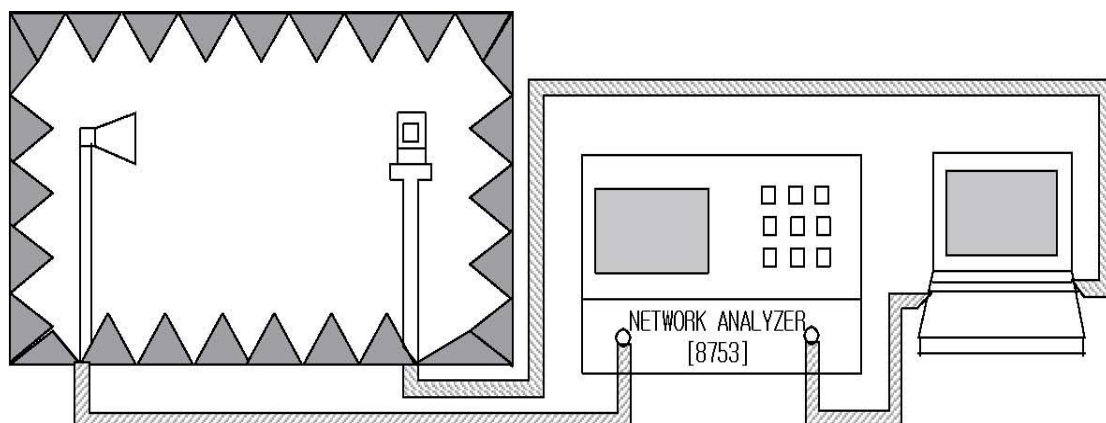
4-1. The measurement of Frequency and VSWR



[Measurement Method]

1. As seen the above, network analyzer is set up for S11 measurement.
2. The measurement frequency range is to set up from 2 GHz to 3 GHz.
3. Perform S11 one port full calibration.
4. Measure the VSWR of three points of Bluetooth frequency range such as 2.4 GHz, 2.45 GHz, and 2.5 GHz.

4-2. The measurement of Gain & Radiation Patterns

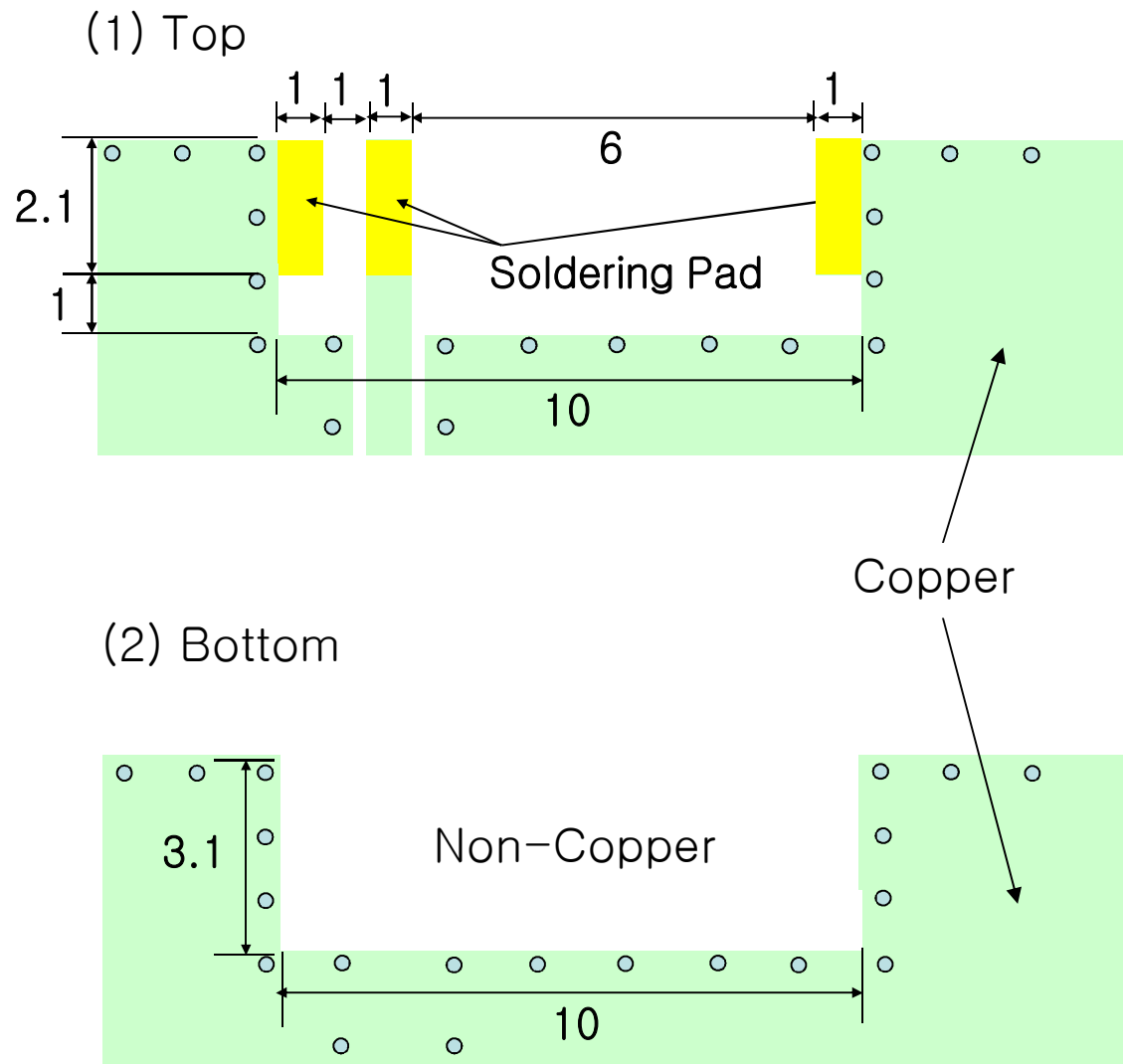


[Measurement Method]

1. As seen the above, network analyzer is to set up in Anechoic chamber.
2. As seen beneath, for the measurement planes as Azimuth, Elevation 1, and Elevation 2, measure Gain data of vertical polarization and horizontal polarization for each plane.

5. PCB Layout & Solder Pad size

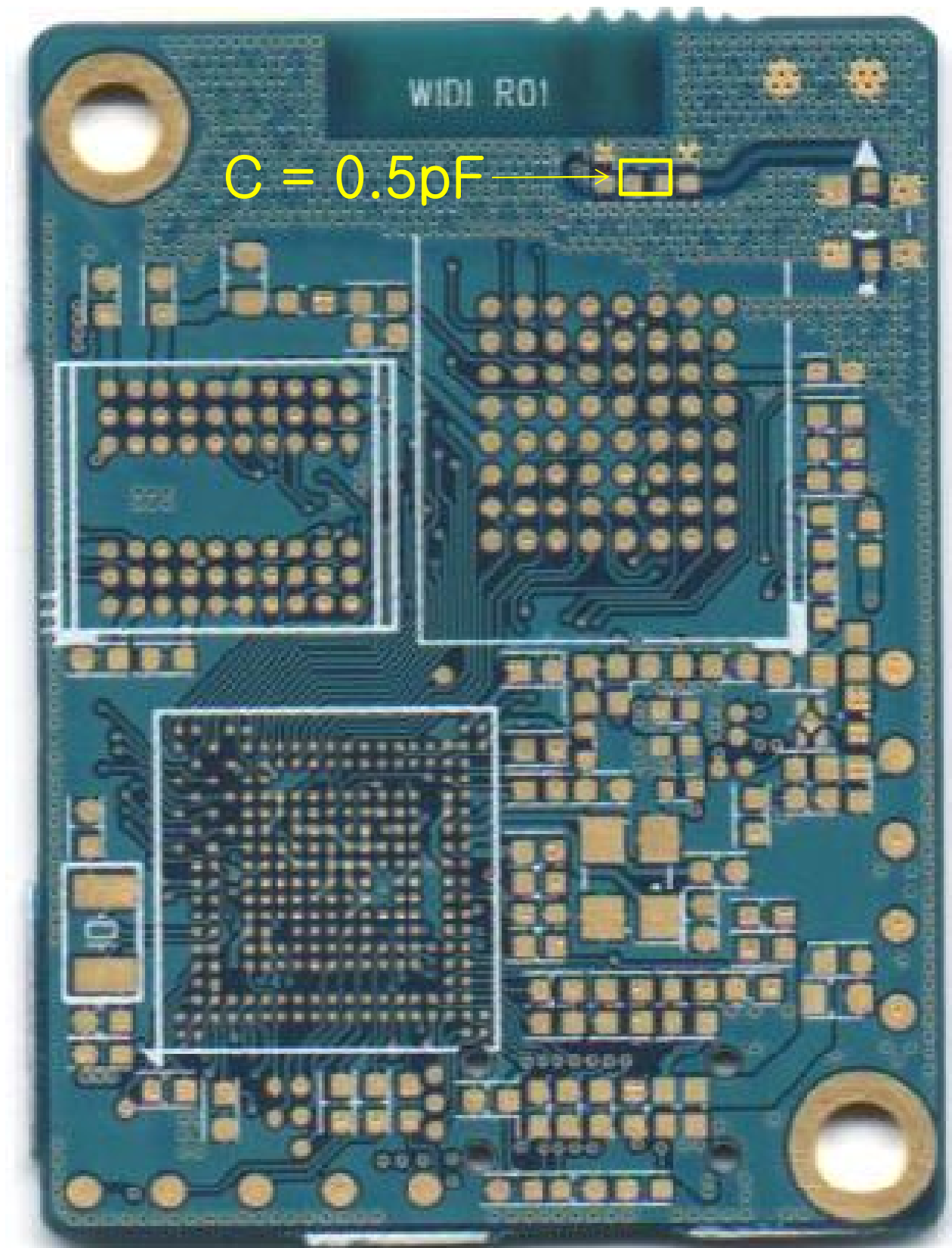
5-1. Layout



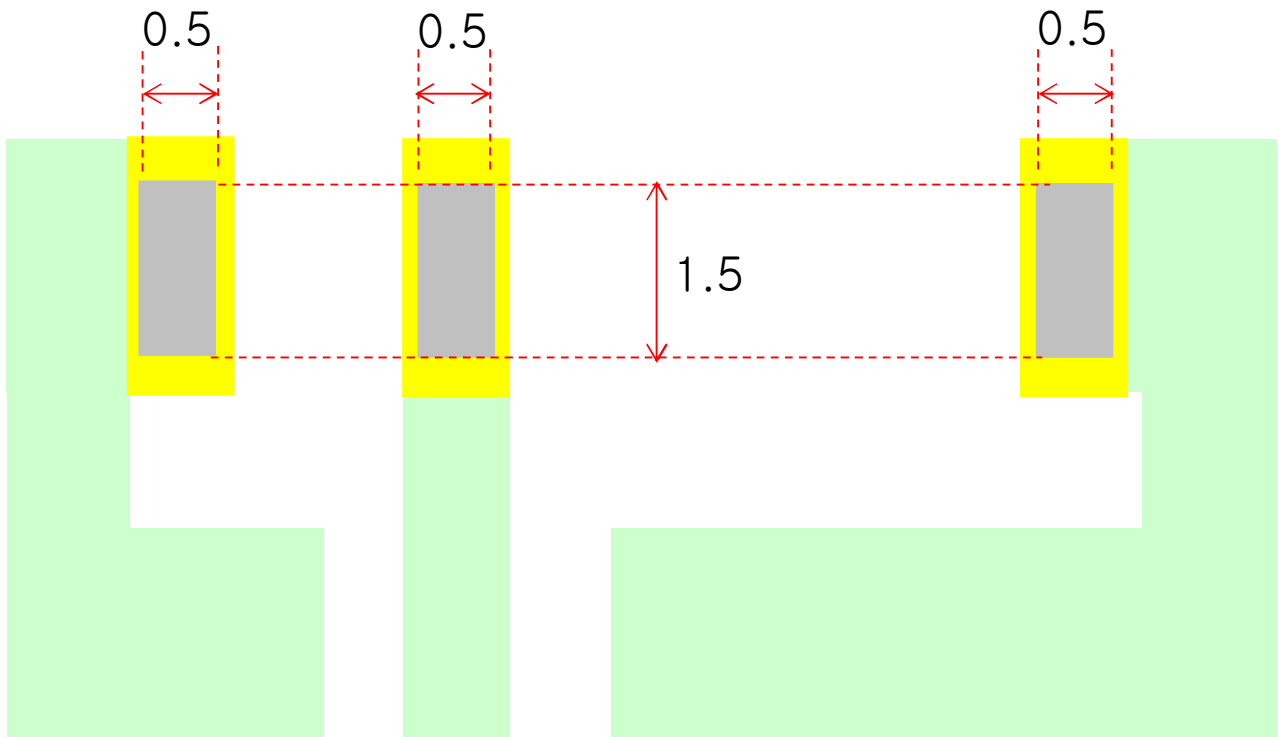
Unit : mm

tolerances : ± 0.05

5-2. Matching Circuits

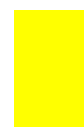


5-3. SOLDERING CREAM AREA



Unit: mm

Soldering Cream의 면적은
SMD 업체 현황(메탈 스크린
두께, 온도)에 따라 변경 될 수
있으므로 협의를 요함

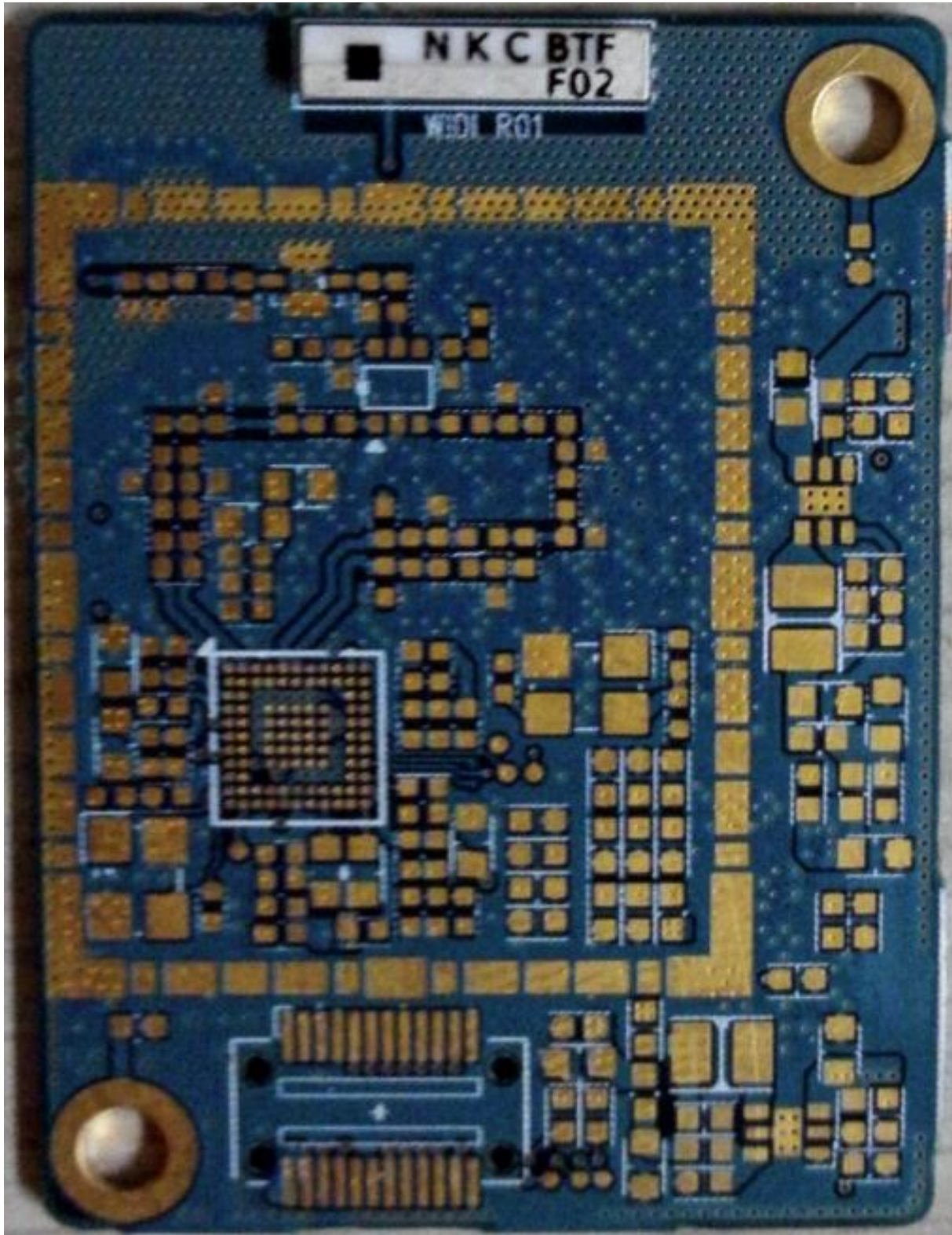


Solder Pad

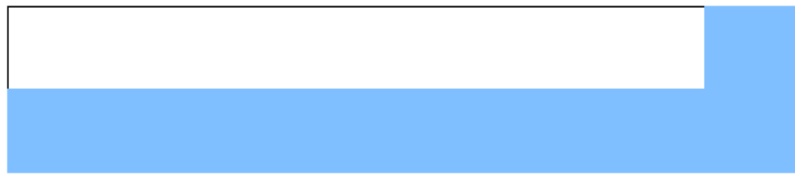


Soldering Cream

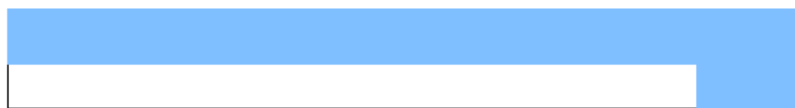
5-4. Antenna position



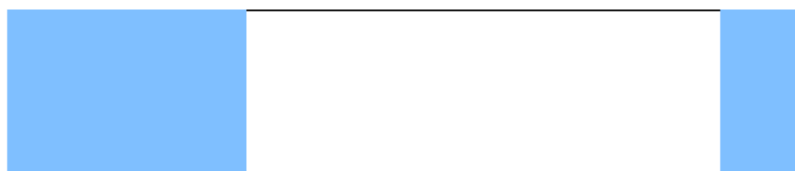
6. Ag pattern



TOP



Side1

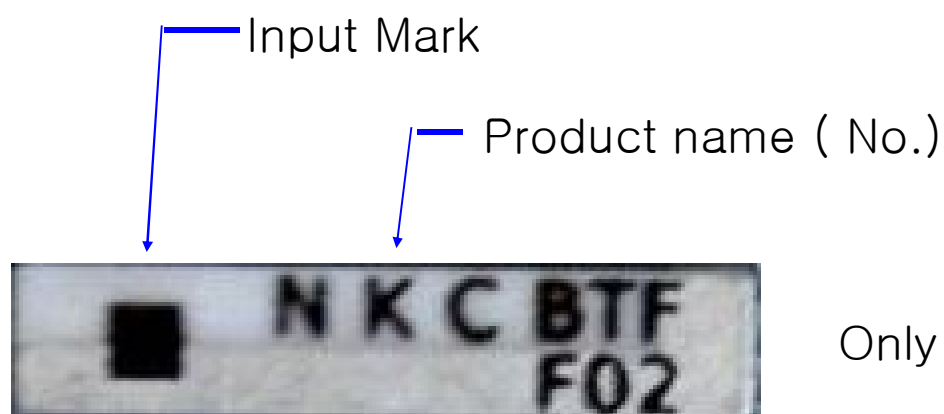


Bottom



Side2

7. Marking View



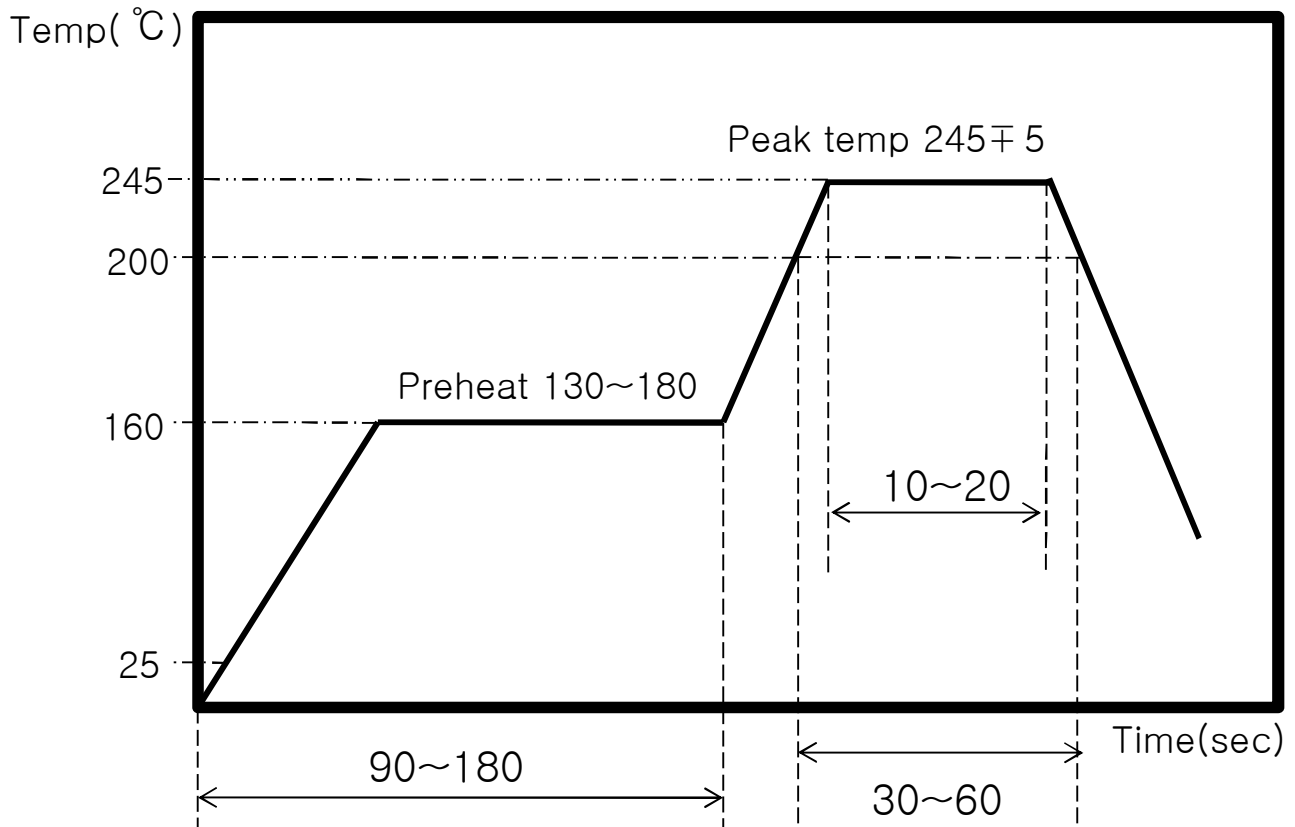
Only TOP part

7-1. 마킹 종류

* RF용 검정 잉크 사용

8. Reflow Profile

8-1. Standard reflow condition(Pb-free)



SMD 업체 현황에 따라 peak temp 및 시간은 변경 될 수 있으므로 협의를 요함

8-2. 수동 납땜 (인두기)을 할 경우(Pb-free)

인두 온도 : 340 'C / 시간 : 각 단 max 3 sec

9. Environmental Tests

No.	ITEM	TEST COND	TEST REQU
1	High Temperature Resistance	1. Temp: $+125\pm 5^{\circ}\text{C}$ 2. Time: $1000\pm 24\text{hrs}$ 3. Measure Fc after left for 24hrs min. at room temp	1. Within electric spec(VSWR) 2. No visual damage
2	Low Temperature Resistance	1. Temp: $-40\pm 5^{\circ}\text{C}$ 2. Time: $1000\pm 24\text{hrs}$ 3. Measure Fc after left for 48hrs min. at room temp	1. Within electric spec(VSWR) 2. No visual damage
3	Thermal Shock	1. 1 cycle/step1: $-40\pm 3^{\circ}\text{C}$, 30min step2: $+125\pm 3^{\circ}\text{C}$, 30min 2. Number of cycle: 30 3. Measure after left for 48hrs min. at room temp	1. Within electric spec(VSWR) 2. No visual damage
4	Humidity	1. Humidity: 85%RH 2. Temp: $+85\pm 3^{\circ}\text{C}$ 3. Time: $1000\pm 24\text{hrs}$ 4. Measure Fc after left for 48hrs min. at room temp	1. Within electric spec(VSWR) 2. No visual damage
5	Adhesive strength of termination	1. Applied force on SMD chip till detached point from PCB. <div data-bbox="523 1556 1018 1886" data-label="Image"> <p>The diagram illustrates the test setup for adhesive strength. It shows a cross-section of a PCB (Printed Circuit Board) with a chip mounted on it. The chip is represented by a vertical stack of colored rectangles (yellow, blue, yellow, blue, yellow). A black arrow labeled 'F' points to the right, indicating the direction of the applied force. The label 'PCB' has an arrow pointing to the left side of the chip, and the label 'chip' has an arrow pointing to the right side of the chip.</p> </div>	1. No mechanical damage by forces applied on the right 2. Strength(F) > 5kgf